

Session Program

2-6 Jun 2025



3rd DRD3 week on Solid State Detectors R&D ***WG5 - Characterization techniques, facilities***

Nikhef, Amsterdam

Friday 6 June

08:30

WG5 - Characterization techniques, facilities

Session | **Location:** Nikhef, Amsterdam

08:30–08:40

Introduction and news

Speakers

Bojan Hiti, Prof. Ivan Vila Alvarez

08:45–09:00

Advancements and future expansions of the Caribou DAQ system

Speaker

Ilias Kamoisis

09:05–09:20

Running Your Test Beam with Constellation

Speaker

Stephan Lachnit

09:25–09:40

High Bandwidth Readout Electronics for TCT in Thin Detectors

Speaker

Andreas Gsponer

09:45–10:00

Double Beam TCT (DB-TCT): new laser method for high rate sensor tests

Speaker

Bojan Hiti

10:05–10:30

Discussion

10:30